
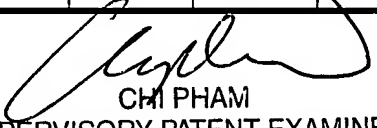


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/071,263	CAIA, JEAN-MICHEL	
	Examiner	Art Unit	
	PHUC H. TRAN	2616	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
370		503			370	242				
INTERNATIONAL CLASSIFICATION										
H	0	4	J	3/06						
				/						
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				/						
				/						
Phuc Tran 10/24/07 (Assistant Examiner) (Date)					 CHI PHAM SUPERVISORY PATENT EXAMINER			Total Claims Allowed: 37		
(Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1		O.G. Print Fig. 2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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